MRD 01-02-02

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Subst. Form PTO-1449 APPLICANT'S(S') INFORMATION DISCLOSURE STATEMENT			Atty. Docket No.: D/A1090 XER 2 0430		Seria	Serial No.: Unknown	
			Applicant(s): Schweid				
			Filing Date: Herewith		Grou	Group: Valinown	
U.S. PATENT DOCUMENTS							
Initial*		Document No.	Date	Name	Class	Subcl.	Filing Date
8	AA	4,723,297	02/02/88	Postl			
*	AB	5,001,766	03/19/91	Baird			
4	AC	5,187,753	02/16/93	Bloomberg et al.			
4	AD	5,355,420	10/11/94	Bloomberg et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		Document No.	Date	Country	Class	Subcl	Translation?
	AL						
	AM						
	AN						
	AO						
	AP						
OTHER ART							
V	AR	"Accurate Skew Estimation and the Top-Down Analysis of Document Images." Baird, Henry S. December 12, 1986.					
<u> </u>							
4	"Measuring Document Image Skew and Orientation." Bloomberg et al. SPIE Symposium in Document Recognition II, 1995.						
							
	ΑT	15					
Examiner:		Se la	·		Date Consi	darad: 1	119/05
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through							
citation if in conformance and not considered. Include copy of this form with next communication to applicant.							